

Notice of References Cited	Application/Control No. 10/510,302		Applicant(s)/Patent Under Reexamination VERWEG ET AL.	
	Examiner ABIY GETACHEW		Art Unit 2841	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,278,178 B1	08-2001	Kwon et al.	257/684
*	B	US-5,440,452	08-1995	Kitahara, Akira	361/773
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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